

10/519034 #
PATENT
450100-05046

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

DT01 Rec'd PCT/PCT 22 DEC 2004

Applicants: Yoshikazu TAKASHIMA et al.

International Application No.: PCT/JP04/004648

International Filing Date: March 31, 2004

For: INFORMATION PROCESSING APPARATUS,
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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP04/004648. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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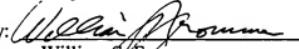
REMARKS

Entry of this Information Disclosure Statement and an early examination on the
merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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Sheet 1 of 1

Based on Form PTO-1449 (3/90)		ATTY. DOCKET NO. 450100-05046	SERIAL NO. 10/519034 Filed Concurrently Herewith
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT Yoshikazu TAKASHIMA et al.	
		FILING DATE Filed Concurrently Herewith	GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5, 784, 528	07/21/98	Yamane et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	JP 2003-87742	03/20/03	Japan			
	AM	WO 97/13365	04/10/97	PCT			
	AN	EP 0 847,198	06/10/98	Europe			
	AO	JP 2003-18549	01/17/03	Japan			
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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